

Technical Information

CK6080WB

RELIABLE TWIN POWER TRIODE

The CK6080WB is a reliable, heater-cathode type, low mu, twin power triode, suitable for operation as a regulator tube in DC power supplies. It is designed for service where conditions of high temperature and mechanical shock or vibration are encountered. Several CK6080WB tubes can be paralleled as desired for increased levels of current or power.

MECHANICAL RATINGS:

Maximum Impact Acceleration (Shock)	450 G
Fatigue (Vibrational Acceleration for extended periods)	2.5 G
Maximum Bulb Temperature	300 °C
Altitude	0,000 ft.

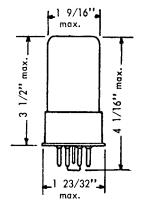
ELECTRICAL DATA

Ratings and Normal Operation	MIL-E-1 Symbol	Test Limit or Absolute Minimum		Normal Operation	Test Limit or Absolute Maximum	MIL_E_I Units
			Ratings			
Heater Voltage	Ef:	6.0	6.3		6.6	٧
Plate Voltage	Eb:		135		250	Vdc
Grid Voltage	Ec:	•••	0		0	Vdc
Heater-Cathode Voltage	Ehk:	-450		•••	+450	V
Cathode Resistance (per cathode)	Rk/k:	•••	250	•••		Ohm s
Grid Resistance (per grid) Note A	Rg/g:		•	•••		Meg.
Grid Current (per grid)	lc/g:	•••			5.0	mAdc
Plate Dissipation (per plate)	Pp/p:	•		•••	13 (Design Max.)	W)
Cathode Current (per cathode)	lk/k:				200	mAdc
			Tests			
Heater Current	lf:	2.35			2.65	Α
Heater Cathode Leakage —(Ehk=±450 Vdc) Note B	lhk:	•••	•••		25	μ Adc
Plate Current (Notes B, C)	lb:	100		125	150	m Adc
Transconductance (Notes B, C)	Sm:	6000		7000	8200	μ mhos
Transconductance (2) (Notes B,C) Ef=5.7V) Δ_{Ef} Sm:			•••	10	%
Plate Current (1) Difference between s	Δ lb: sections		* # #		25	mAdc

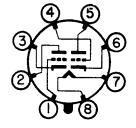
MECHANICAL DATA

ENVELOPET-12 G	lass
BASE B8	-98
CATHODE: Coated Unipoter	ntial
BASING	8BD
MOUNTING POSITION	Anv

PHYSICAL DIMENSIONS



BASING



BOTTOM VIEW

TERMINAL CONNECTIONS:

Pin 1	Grid, Unit #2
Pin 2	Plate, Unit #2
Pin 3	Cathode, Unit #2
Pin 4	Grid, Unit #1
Pin 5	Plate, Unit #1

Pin 6 Cathode, Unit #1

Pin 7 Heater Pin 8 Heater



Ratings and Normal Operations	MIL-E-1 Symbol	Test Limit or Absolute Minimum	Normal Test Conditions	Normal Operation	Test Limit or Absolute Maximum	MIL-E-1 Units
			Tests			
Amplification (Notes B,C,D)	Mυ:	1.5		•••	2.5	
Vibration (2) Rp=2000: Ec=-7Vdc (Note D) Rk=0, F=50-500 cps. G=2.5	Ep:				500	mVac
Plate Current (2) Eb=250Vdc; Ec=-200Vdc (Notes B,C)	lb:	•••		•••	10	mAdc

SPECIAL TESTS AND RATINGS TO INSURE RELIABILITY.

Randomly selected statistical samples are subjected to the following tests:

Shock Test -	450G. 30° hammer angle in Navy high impact shock machine. Sample subjected to twenty impact accelerations, five impact accelerations in each of four different positions.
Fatigue Test —	2.5G. Sample subjected to vibrational acceleration of 2.5G for 96 hours (32 hours in each of three positions). The sinusoidal vibration is applied at a sweep frequency of 50 to 500 and back to 50 cps. Ef=6.3V, no other voltage applied.
Heater—Cycling Life Test—	A sample is subjected to 2000 on—off heater cycles at the following conditions. Ef=7.5 V Ehk = 300 Vac and other elements floating. At the conclusion of this test the tubes will not show open heater or cathode circuits, heater-cathode shorts, or heater-cathode leakage current in excess of 50 μ Adc.
Stability Life Test-	Sample is operated for one hour to assure initial electrical stability (Δ_{t} Sm < 10%). Tubes operated at room temperature ambient with Eb=150; Ehk=300Vac; Rk/k=400.
Survival Rate Life Test —	Sample is operated one hundred hours to assure electrical stability (Sm $>$ 5800 μ mhos) and freedom from inoperatives. Tubes are operated at Stability Life Test conditions.
Intermittent Life Test —	1000 hours. Sample is operated with minimum Envelope Temperature of 300 $^{\circ}$ C. Tubes are operated at Stability Life Test conditions.
Altitude —	Sample is subjected to a pressure of 55+5 mmHg (60,000 ft) at 500 Vac to assure freedom from flashover of corona at the pins of the tube.

APPLICATION NOTES

CAUTION — To Electronic Equipment Design Engineers: Special attention should be given to the temperature at which the tubes are to be operated. Reliability will be seriously impaired if maximum bulb temperature is exceeded. The life expectancy may be reduced if conditions other than those specified for life test are imposed on the tube and will be reduced appreciably if maximum ratings are exceeded. Both reliability and performance will be jeopardized if filament voltage ratings are exceeded. Life and reliability of performance are closely related to the degree that regulation of the heater voltage is maintained at its center rated value.



Note A: Maximum grid circuit resistance:

(a) 1.0 megohm for Cathode-bias operation.

(b) 0.1 megohm for fixed bias operation.

(c) 0.1 megohm for combined fixed and cathode-bias operation.

Note B: Test each unit separately.

Note C: Both units shall be operating.

Note D: Units connected in parallel.

ACCEPTANCE CRITERIA

The following tests shall be performed:

TEST CONDITIONS

For the purpose of Inspection, use applicable reliable paragraphs of MIL-E-1

For miscellaneous requirements, see Paragraph 3.6.

 $\begin{array}{lll} \mbox{Heater Voltage} & 6.3 \ \mbox{V} \\ \mbox{Plate Voltage} & 135 \ \mbox{Vdc} \\ \mbox{Grid Voltage} & 0 \ \mbox{Vdc} \\ \mbox{Cathode Resistance (per cathode)} & 250 \ \mbox{Ω} \end{array}$

Ref. Test		Conditions	AQL (Percent	Inspection Level or	Symbol	LIMITS (See Note 4)						Units
			Defective)	Code		Min	LAL	Bogie	UAL	Max	ALD	1
QUALI	FICATION APPROVAL TE	STS										
3.1	Qualification Approval:	Required for JAN Marking	g									
4.9.4	Base Material:	l i						i				
	Cathode:	Coated Unipotential			-							
3.4.3	Base Connections:	B8-98								·		
4.9.20.3	Vibration(1):	Ecl=-7Vdc; Rk=0; Rp=2000 ohms; Note 2	•••	•	Ep:					500		mVac
MEAS	I UREMENTS ACCEPTANCE	 E TESTS, PART 1, NOTE	3									
4.10.8	Heater Current:		0.65	11	lf:	2.35				2.65		A
4.10.15	Heater-Cathode Leakage:	Note 1 Ehk=+450Vdc Ehk=-450Vdc	.65	11	lhk:					25 25		μAdc μAdc
4.10.6.1	†Grid Current:	Rg=1.0 Meg; Rk=125 ohms; Note 2	.65	11	lc:	0				-1.0		μAdc
4.10.4.1	†Plate Current(1):	Notes 1,5	.65	11	lb:	100				150		mAdc
4.10.4.1	Plate Current(1):	Notes 1,5			lb:		115	125	135		25	mAdc
4.10.9	Transconductance(1):	Notes 1,5,7	.65	11	Sm:	6000				8200	 	μ mhos
4.10.9	Transconductance(1):	Notes 1,5,7	•••		Sm:		6600	7000	7400		1000	μmhos
4.7.5	Continuity and Shorts (Inoperatives)		.4	11		•••				•••		
4.9.1	Mechanical	Envelope Outline per Figure 1	•••			•••						
MEAS	UREMENTS ACCEPTANCE	TESTS, PART 2										
4.8	Insulation of Electrodes:	Eg-all=-100Vdc Ep-all=-300Vdc Note 1	2.5	L6	R: R:	200 200						Meg Meg
4.10.9	Transconductance(2):	Ef=5.7V: Notes 1,5,7	2.5	1	Δ_{Ff} Sm:					10		%
4.9.12.1	Low Pressure Voltage Breakdown:	Pressure=55+5mm Hg.; Voltage=500Vac	6.5	Note 6					•••			



Ref.	Test	Conditions	AQL (Percent	Inspection Level or	Symbol	LIMITS (See Note 4)						Units
			Defective	Code		Min.	LAL	Bogie	UAL	Max	ALD	
MEAS	UREMENTS ACCEPTAN	 CE TESTS, PART 2 (Cont.)										
4.10.4.1	Plate Current(1) Difference Between Sections:		2.5	I	Δlb:	•••	•••			25		mAdc
4.10.11.1	Amplification Factor:	Rk=250 ohms; Notes 1,5,7	6.5	Code G	Mu:	1.5	•••	•••		2.5		
•••	Vibration(2):	Rk=0; Rp=2000; Ec= -7Vdc; F=50-500 cps; G=2.5; Note 19	6.5	Code G	Ep:		• • •	•		500		mVac
4.10.4.1	Plate Current(2):	Eb=250Vdc; Ec=200 Vdc; Notes 1,5	2.5	I	lb:					10		mAdc
DEGR	ADATION RATE ACCEP	TANCE TESTS, NOTE 8										
4.9.20.5	Shock:	Hammer angle =30°; Ehk=+450Vdc; Ec=-7Vdc; Rp=2000 ohms; Rk=0; Note 2										
	Fatigue:	F=50-500 cps; G=2.5; Ef=6.3 V; no other voltages applied; Note 19, except t=96 hours	6.5	Note 6						•••		
	Post Shock and Fatigue End Points:	Vibration Heater-Cathode Leakage Ehk=+450Vdc Ehk=–450Vdc Transconductance(1)	 	 	Ep: Ihk: Ihk: $\Delta_{\mathbf{j}}$ Sm:					500 50 50 10		mVac μAdc μAdc %
		Grid Current		•••	lc:					-1.5		μAdc

Ref.		Conditions	AQL		per Cho	e Defectives aracteristic	•	LIMITS		
	Test		(Percent Defective)	Inspection Level or Code	First Sample	Combined Samples	Sym.	Min	Max	Units
ACCE	PTANCE LIFE TESTS,	NOTE 8								
4.11.7	Heater Cycling Life Test:	Ef=7.5V; Ehk=300Vac; Eb=Ec=0; 1 min. on 4 min. off; Note 9							•••	
4.11.4	Heater Cycling Life Test End Points:	Heater-Cathode Leakage Ehk=+450Vdc Ehk=-450Vdc					Ihk: Ihk:		50 50	μAdc μAdc
•••	Stability Life Test: (1 hour)	Eb=150; Ehk=300Vac; Rk/k=400; TA=Room; Notes 1,10	1.0	Code I						
4.11.4	Stability Life Test End Points:	Change in Transconduc- tance(1) of individual tubes					$\Delta_{\!\scriptscriptstyle{f t}}$ Sm:		10	%
•••	Survival Rate Life Tests (100 hours)	Stability Life Test Condi- tions or Equivalent; Notes 11,12		I#						
4.11.4	Survival Rate Life Test End Points:	Continuity and Shorts (Inoperatives) Transconductance(1)	0.65				Sm:	5800		μmhos.
4.11.5	Intermittent Life Test:	Stability Life Test Conditions; T Envelope= 300°C min; Notes 13,14								



			401		per Cho	e Defectives gracteristic		LIMITS		
Ref. Test	Conditions	AQL (Percent Defective)	Inspection Level or Code	First Sample	Combined Samples	Sym.	Min	Max	Units	
ACCEP	TANCE LIFE TESTS, N	OTE 8 (Cont.)								
4.11.4	Intermittent Life Test End Points, (1000 hrs)	Notes 15,17 Inoperatives; Note 16 Grid Current Transconductance(2) Heater-Cathode Leakage Ehk=+450Vdc Ehk=-450Vdc Heater Current Change in Transconductance(1) of individual tubes Insulation of Electrodes g-all p-all			1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	33333333333	$egin{array}{c} & \ \Delta_{Ef} Sm \colon \\ \Delta_{hk} & \ lhk \colon \\ lhk & \ lf \colon \\ \Delta_{t} Sm \colon \\ & \ R \colon \\ & \ R \colon \\ & \ R \colon \end{aligned}$	2.35	25 25 275 15	µAdc % µAdc µAdc A %
4.11.5	Intermittent Life Test: (5000 hour Information)	Note 20								
PACKA	I GING REQUIREMENTS									
4.9.18.1.1	Container Drop:	(d) Package Group 1; Container Size G								

- Note 1: Test each unit separately.
- Note 2: Tie 1k to 2k; 1g to 2g; and 1p to 2p.
- Note 3: The AQL for the combined defectives for attributes in Measurements Acceptance Tests, Part 1, excluding Inoperatives and Mechanical, shall be one (1) percent. A tube having one (1) or more defects shall be counted as one (1) defective. MIL-STD-105, Inspection Level II shall apply.
- Note 4: Variables Sampling Procedure:

See paragraphs 5.3.3 to 5.3.3.4, inclusive, of the Inspection Instructions for Electron Tubes.

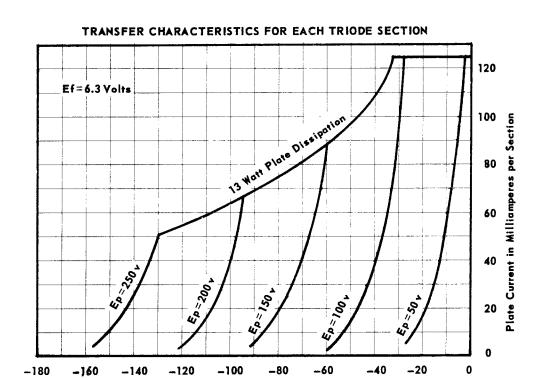
- Note 5: Both units shall be operating.
- Note 6: This test shall be conducted on the initial lot and thereafter on a lot approximately every 30 days. When one lot has passed, the 30-day rule shall apply. In the event of lot failure, the lot shall be rejected and the succeeding lots shall be subjected to this test until a lot passes. MIL-STD-105, sample size code letter F shall apply.
- Note 7: Rk bypassed with 1000 μf capacitor.
- Note 8: Destructive Tests: Tubes subjected to the following destructive tests are not to be accepted under this specification.
 - 4.9.20.5 Shock
 - 4.9.20.6 Fatigue
 - 4.11.7 Heater-Cycling Life Test
 - 4.11.5 Intermittent Life Test

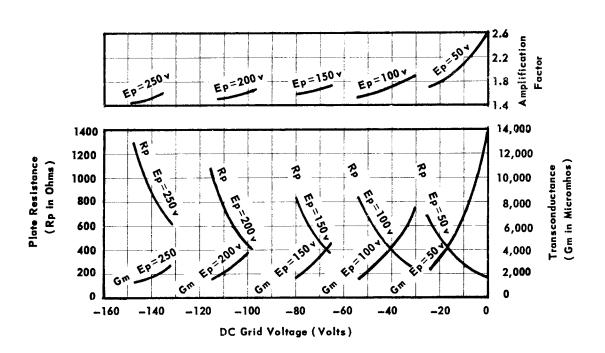


NOTES: (Cont'd)

- Note 9: The no-load to steady state full load regulation of the heater voltage supply shall be not more than 3.0 percent. This test shall be made on a lot by lot basis. A failure or defect shall consist of an open heater, open cathode circuit, heater—cathode short, or heater—cathode leadage current in excess of the specified heater cycling life test end point limit.
- Note 10: <u>Stability Life Test:</u> The sampling and testing procedures for this test shall be in accordance with paragraphs 5.3.4.1(a) to 5.3.4.1(g), inclusive, of the Inspection Instructions for Electron Tubes.
- Note 11: <u>SURVIVAL RATE LIFE TEST</u>: The sampling and testing procedures for this test shall be as defined in paragraphs 5.3.4.2 to 5.3.4.2.4, inclusive, of the Inspection Instructions for Electron Tubes.
- Note 12: For Survival Rate Life Test, the equivalent Stability Life Test conditions shall be as defined in paragraph 5.3.4.2.5 of the Inspection Instructions for Electron Tubes.
- Note 13: <u>Intermittent Life Test:</u> Sampling and acceptance procedures for these tubes shall be as defined in paragraphs 5.3.4.3(a) to 5.3.4.3(i), inclusive, of the Inspection Instructions for Electron Tubes, except for the following:
 - a. Under Par. 5.3.4.3 d (2), delete reference to 500 hour requirements.
 - b. Delete Par. 5.3.4.3. e (1).
 - c. Add to Par. 5.3.4.3 e (2): "The life test sample meets the 1000 hour life requirements at 500 hours".
 - d. Under Par. 5.3.4.3 e (3), replace "500 hours" with "1000 hours".
- Note 14: Envelope Temperature is defined as the highest temperature indicated when using a thermocouple of #40 BS or smaller diameter elements placed in contact with the envelope. Envelope Temperature requirement will be satisfied if tube, having bogie lb (±5%) under normal test conditions, is determined to operate at minimum specified temperature at any position in the life test rack.
- Note 15: Order for Evaluation of Life Test Defects: See Paragraph 5.3.4.4 of the Inspection Instructions for Electron Tubes.
- Note 16: An inoperative as referenced in Life Test is defined as a tube having one (1) or more of the following defects: discontinuity (Ref. MIL-E-1, par. 4.7.1), shorts (Ref. MIL-E-1, par. 4.7.2), air leaks (Ref. MIL-E-1, par. 3.2.4.3).
- Note 17: The total allowable combined defectives for Inoperatives, Grid Current and Transconductance(2) shall be 2 and 5, for first sample and combined samples, respectively. The total allowable combined defectives for Heater-Cathode Leakage, Heater Current, Change in Transconductance(1) of Individual Tubes and Insulation of Electrodes (g—all and p—all), shall be 3 and 6 for first sample and combined samples, respectively.
- Note 18: Maximum grid circuit resistance:
 - (a) 1.0 megohm for Cathode-bias operation.
 - (b) 0.1 megohm for fixed bias operation.
 - (c) 0.1 megohm for combined fixed and cathode-bias operation.
- Note 19: Vibration and Fatigue Test Procedure
 - (a) This test is to be performed with an average acceleration level equal to the specified value while being swept continuously during a time of approximately one(1) minute through the frequency range of 50 to 500 and back to 50 cycles per second.
 - (b) The total excitation time for the test shall not be less than three (3) minutes. The tubes shall be mounted in each of three planes X-1, X-2 and Y-1 for one third of the total excitation time. In each mounting plane, the tubes shall experience at least one complete frequency sweep.
- Note 20: Ten percent (10%) of the tubes placed on life for the 1000 hour test shall be continued on life until failure or 5000 hours have elapsed for the purpose of data collection to substantiate life expectancy. Five (5) copies of these data shall be forwarded to the Armed Services Electro-Standards Agency, Fort Monmouth, New Jersey, for information and evaluation.







Grid Voltage





